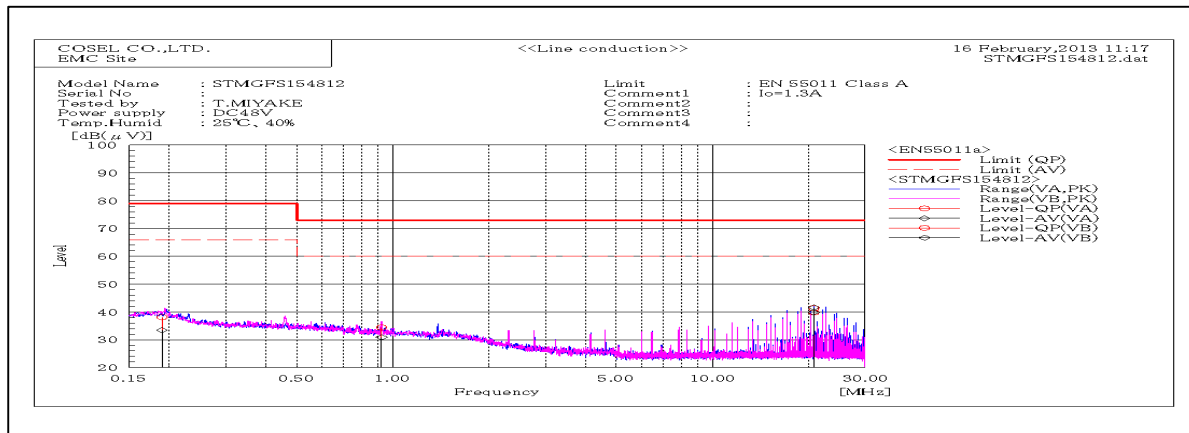
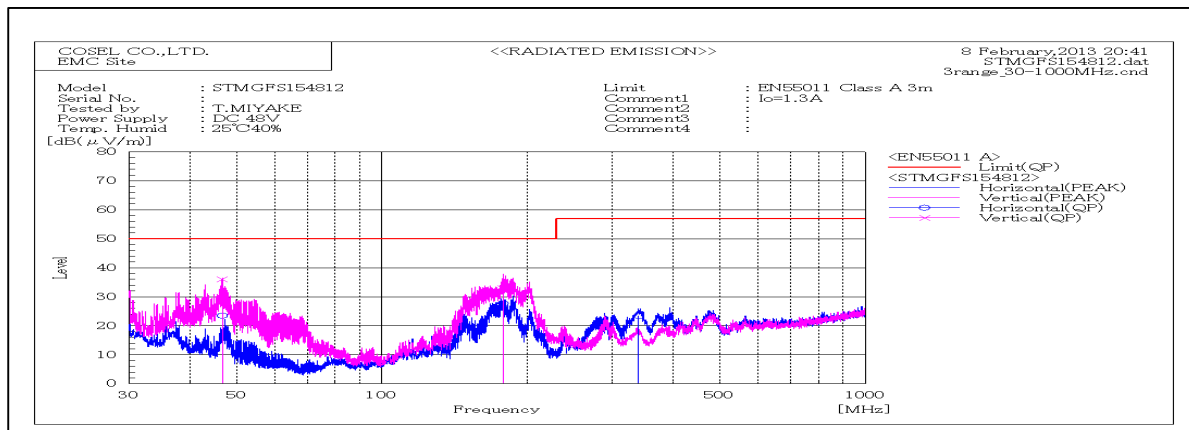


DATA SHEET		Date	18-Feb-13
Model	STMGFS154812	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake



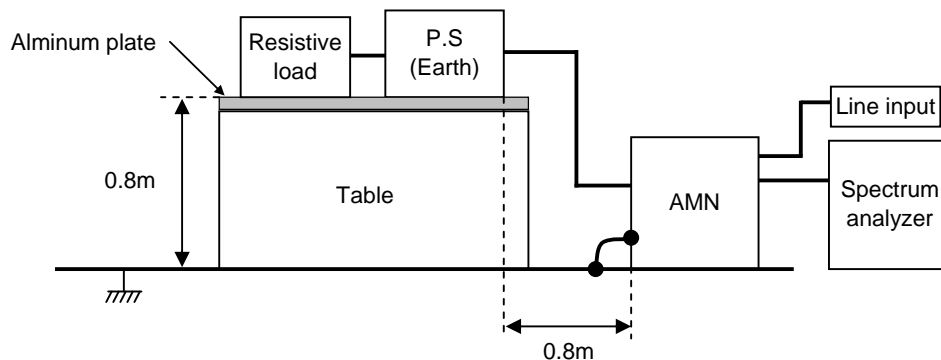
Frequency MHz	Harm	Line Phase	Reading dB(uV)		Factor dB	Level dB(uV)		Limit dB(uV)		Margin dB		Pass/ Fail	Remark
			QP	AV		QP	AV	QP	AV	QP	AV		
0.18988		VB	17.9	13.3	20.2	38.1	33.5	79	66	40.9	32.5	Pass	
0.92305		VA	14.4	10.8	20.1	34.5	30.9	73	60	38.5	29.1	Pass	
20.7425		VB	18.6	18.7	21.2	39.8	39.9	73	60	33.2	20.1	Pass	
20.74025		VA	20.2	20.3	21.2	41.4	41.5	73	60	31.6	18.5	Pass	



Frequency MHz	Polarization	Stability	Reading dB(uV)		Space Loss dB	Level dB(mW)		Margin dB	Pass/Fail	Height cm	Angle deg	Remark
			QP	AV		QP	AV					
46.746	V	Stable	57.8	-21.8	36	50	14	Pass	102	79		
46.752	H	Stable	46.5	-23	23.5	50	26.5	Pass	158	180		
177.981	V	Stable	49	-16	33	50	17	Pass	102	0		
178.2	H	Stable	50.1	-22.3	27.8	50	22.2	Pass	152	275		
340.023	H	Stable	37.5	-14.1	23.4	57	33.6	Pass	112	91		

DATA SHEET		Date	18-Feb-13
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	T.Miyake

1. Line conduction



2. Radiated emission

